
Analysis Meeting – 08/10/2012

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Software status

https://forge.in2p3.fr/projects/calice/wiki/DESY_2012-07_Analysis
(installed on LLR DAQ PC since June, on forge since August !!)

- **Raw files conversion:** Raw2Root.C
 - 1 ROOT file per layer
 - No cut (Keep all informations)
 - Flag BCID+1 events
 - **ROOT files Merging:** mergeRootFiles.C
 - Keep all informations
 - **Reconstruction:** ObjectBuilder.C
 - Group hits with the same BCID (tolerance +1 in others chips)
 - Cut BCID+1 events
 - Flag plane events (Nhits in 1 chip > 20)
 - File content:
 - Hit: energy, position (pad position, channel number, chip number)
 - Time (spill number + BCID)
 - Nhits
 - EventType
 - **Event Display:** Plot3D_Obj.C
- To do: pedestal subtraction

Simulation Status

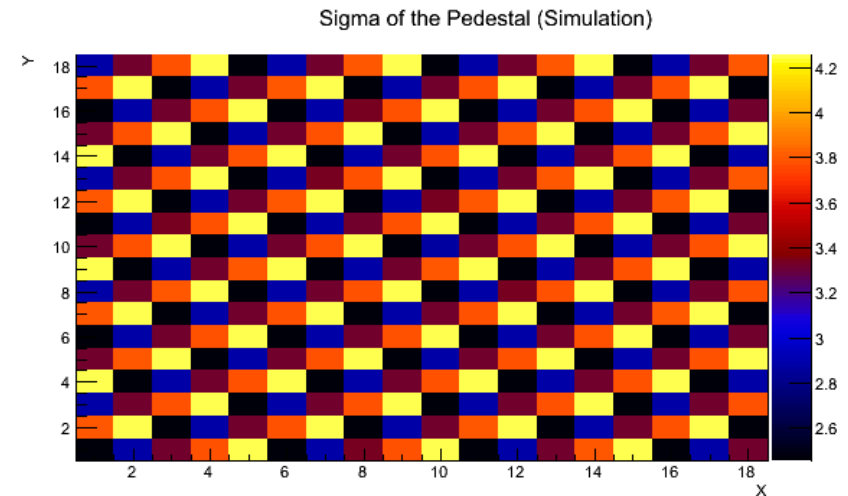
- **Geometry:**
 - Detailed description of the detector geometry
 - Simple script to modify configuration
- **Beam:**
 - Direction: almost OK
 - To do : check position
 - Correlation between particle position and beam direction?
- **Output:** same root file structure (1 chip, 1 column, 324 channels)
==> same analysis tools
- **Simple digitization**

==> waiting for feedback

Energy measurement in simulation - Digitization

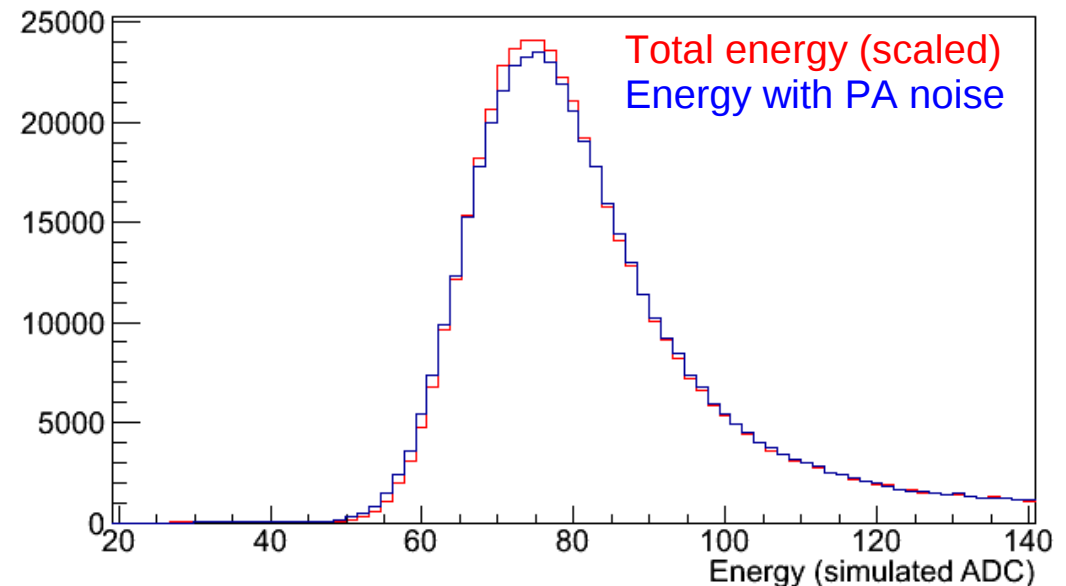
Keep all informations in the ROOT file!!

- Total energy deposited in one pixel (in keV)
- Geometrical cuts (inter-pixel gap) (in keV)
- Electron-hole pair production fluctuation (in keV)
- Electron-hole transport diffusion (in keV)
- Scaling using the landau MPV ($1/1.27 \rightarrow$ in ADC)
- + Add PA noise (sigma from 2 to 4 ADC)



- Apply trigger threshold (scan trigger threshold \rightarrow detection efficiency...)

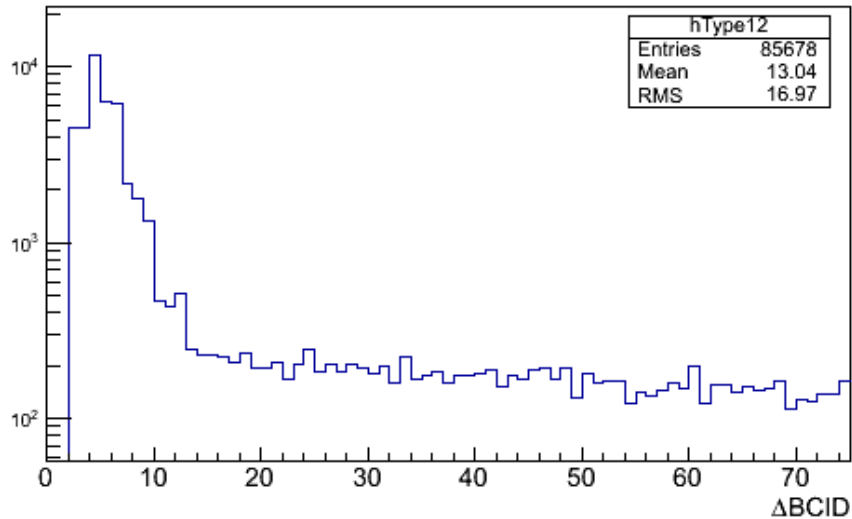
- Add SS noise (sigma = 1.4 ADC)
- Add pedestal (+300 ADC)



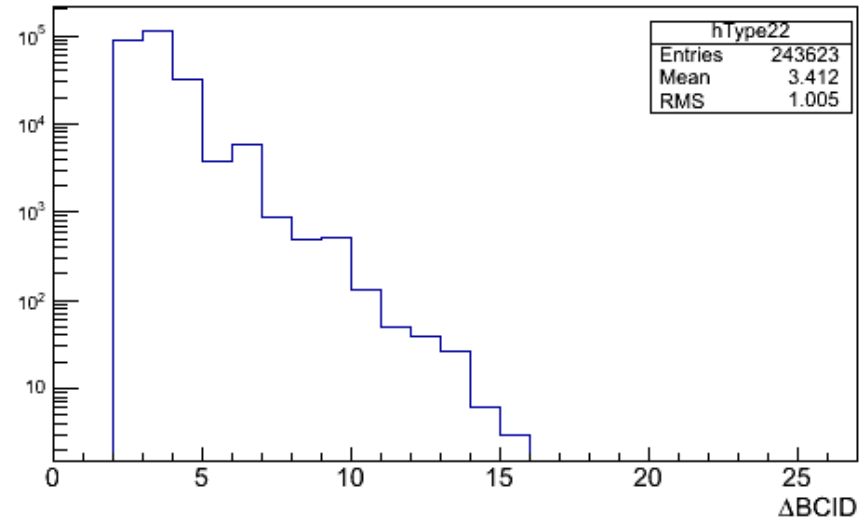
Data quality

Plane events

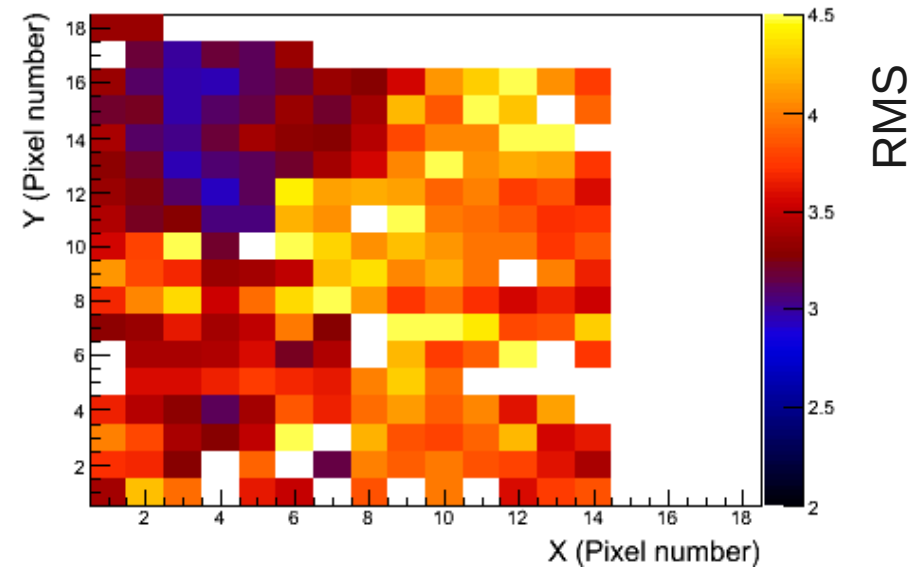
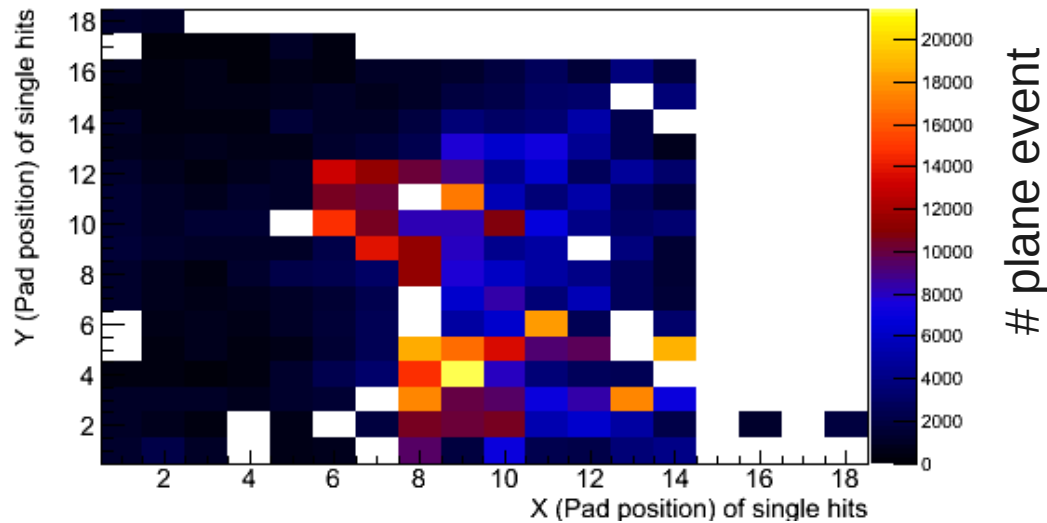
after single hits



after same type of events



Pedestal RMS - layer 2



Is it just a map of noisy channels?
Is some channels induced plane events?

Need further investigations!

BCID+1 and Plane events

BCID+1
Plane Evts

- 2 acquisitions, centered, no W

0: chip M1: 30% – 20-25% , others chips 10-15% – 6-9%

1: chip M1: 40% – 25-30% , others chips 10-15% – 6-9%

2: chip M1: 43% – 30% , others chips 12-20% – 10-15%

3: chip M1: 45% – 40% , others chips 30-40% – 20-30%

4: chip M1: 53% – 20-25% , others chips 20-30% – 15-18%

5: chip M1: 52% – 20-25% , others chips 20-30% – 15-18%

More
bad
events

==> increase from 0 to 4, 1 ~ 2, 5 ~ 3 or 4

- % of bad events compared with Nevt in the chip

--> not appropriated (plane events does not occur in the same chip than previous hits)

- chip= 1 Evt= 17475 - 39.6% - 26.9%

- chip= 2 Evt= 125130 - 9.6% - 3.1%

- chip=3 Evt= 17325 - 40.7% - 26.6%

- chip= 4 Evt= 121305 - 8.9% - 4.0%

Some events are plane and BCID+1

BCID+1 and Plane events

BCID+1
Plane Evts

- Increase with shower developpement
 - Ex: 5 GeV – 6X0 in front of the detector + W plates - layer 4
 - chip= 1 Evt= 240300 - 71.7% - 43.2%
 - chip= 2 Evt= 244185 - 57.7% - 64.7%
 - chip= 3 Evt= 246015 - 72.8% - 53.8%
 - chip= 4 Evt= 231495 - 66.0% - 64.8%

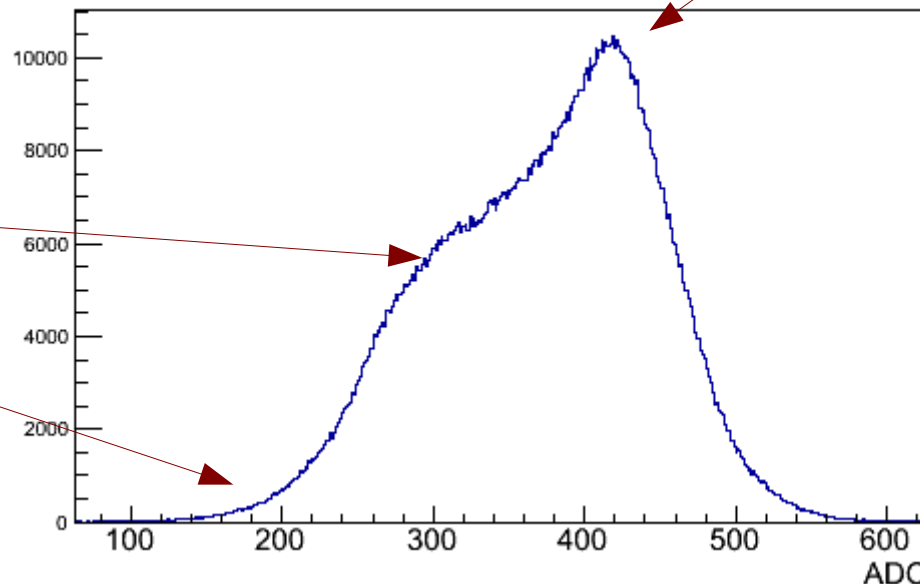
Some events are plane and BCID+1

Isolated hits

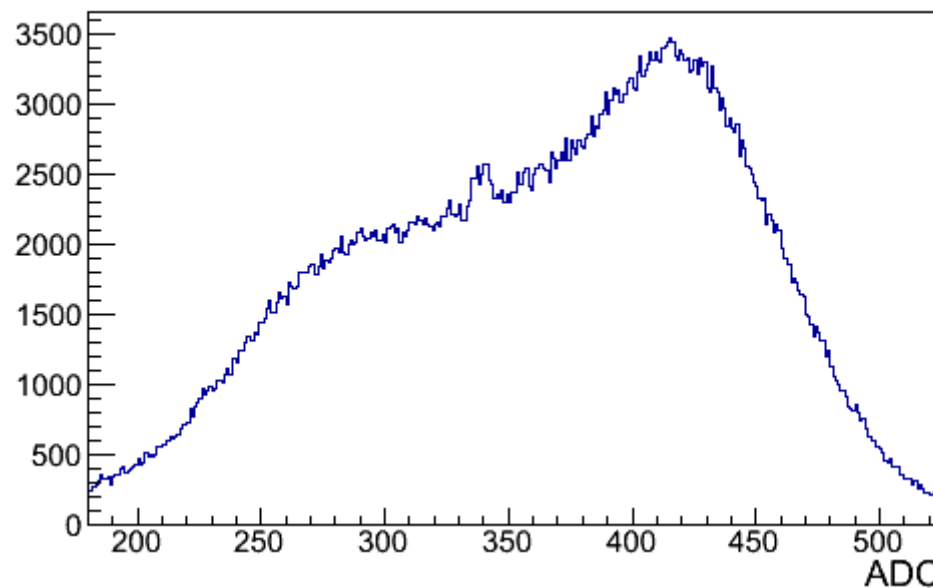
- Reconstructed events with only 1 layer with hits:

- No W: ~30%

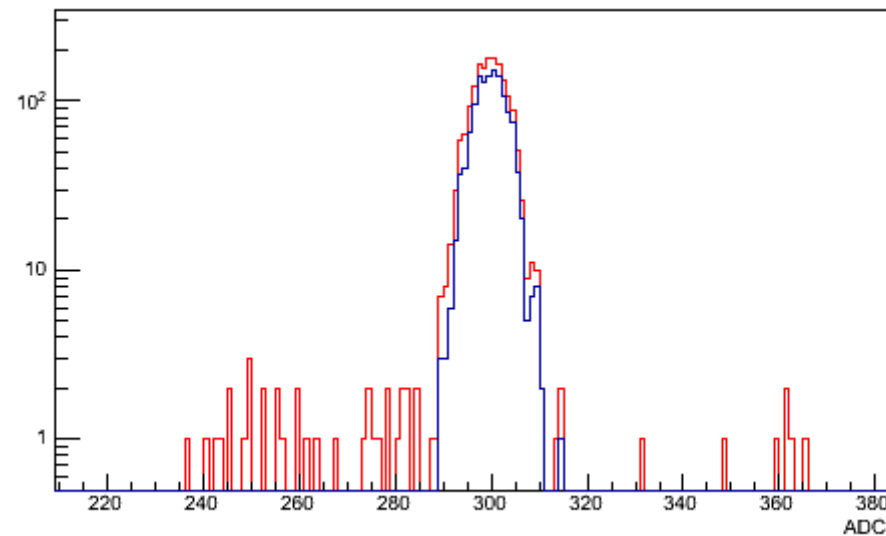
Pedestal?
Huge tails



- Shower: ~10%



Pedestal filtering



Same channel

Red: all events

Blue: remove all events of the spill if 1 plane event in the spill

==> Plane event at BCID=1000 correlated with bad pedestal at BCID 500 ???

MIP Reconstruction – Beam studies

MIP reconstruction - Beam studies

Fit function:

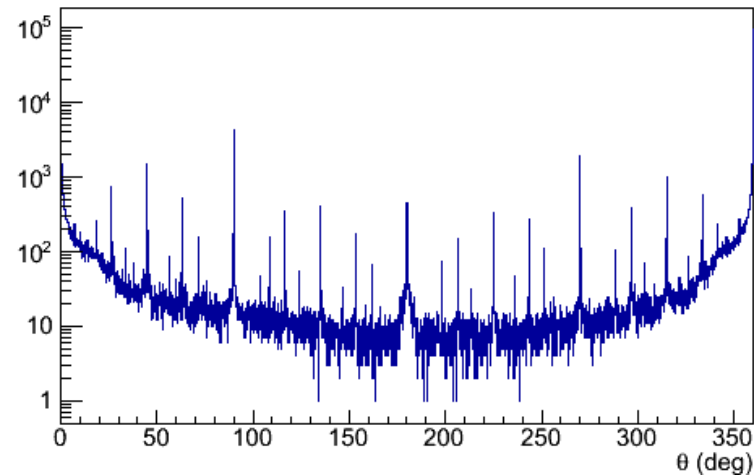
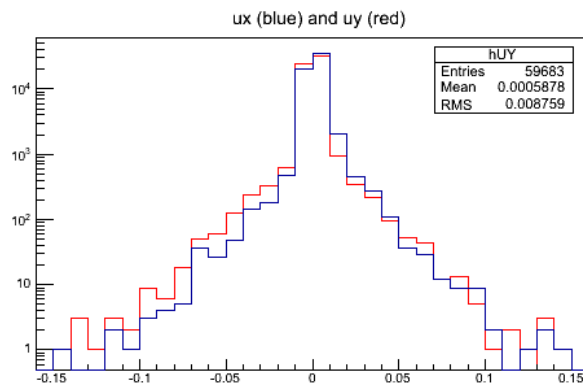
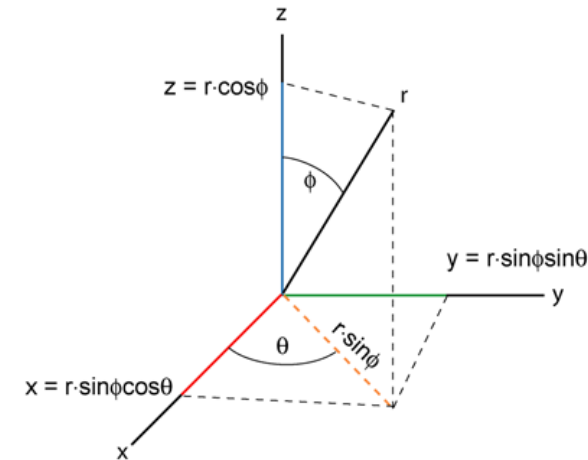
$$x = x_0 + k.u_x$$

$$y = y_0 + k.u_y$$

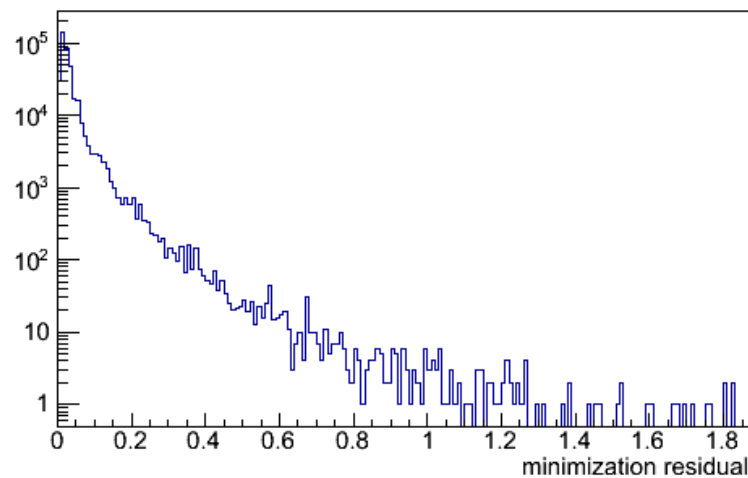
$$z = k.u_z$$

=>

spherical coordinates



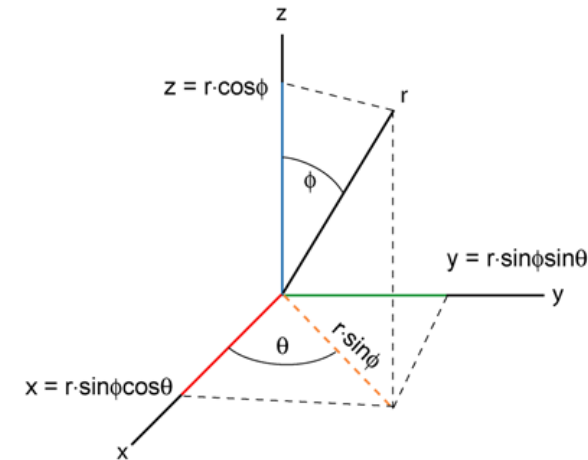
D = distance (Track – hit) ==> minimize: Sum(D x Exp(D-pixelEdge))



MIP reconstruction - Beam studies

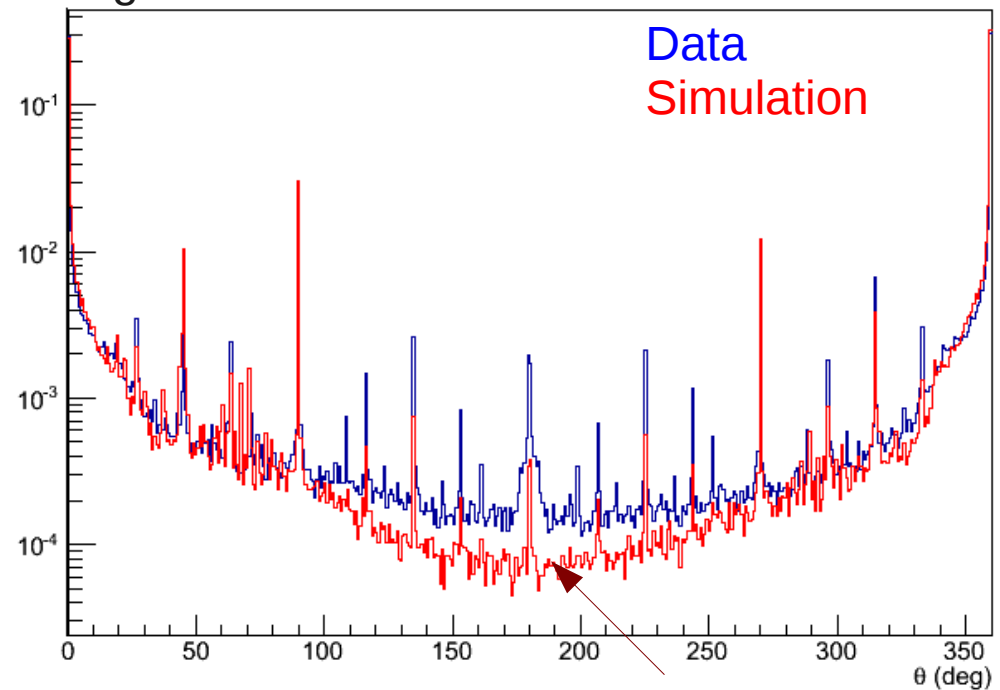
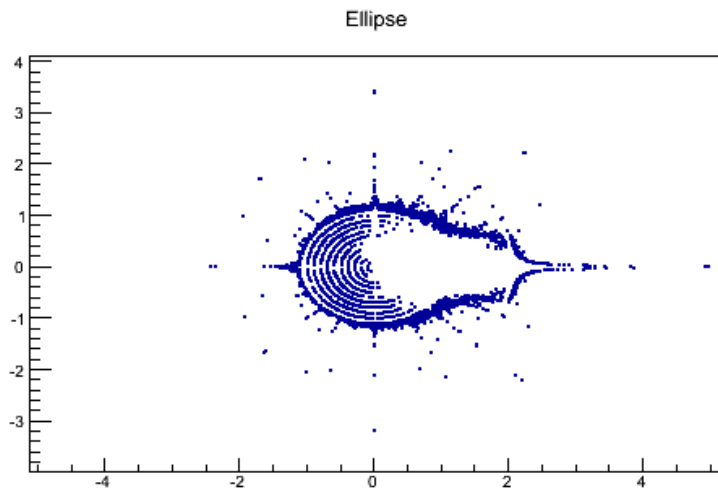
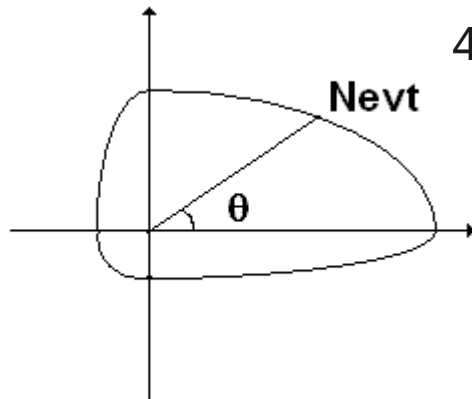
Beam reconstruction

- Theta:
beam slightly deflected in X direction
=> detector alignment?, fake effect due to layer alignment?



4 part ellipse:

- Construct using main axis
- Randomly chosen using area



Typo in code

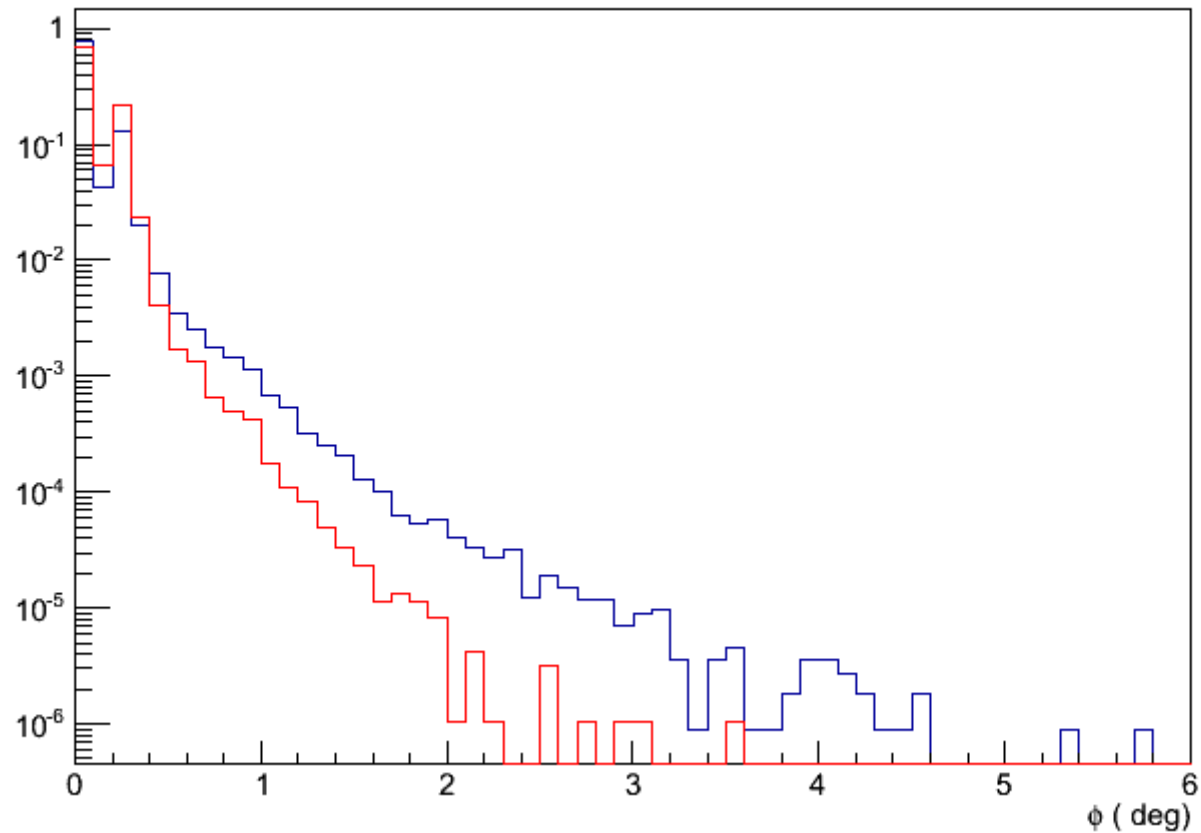
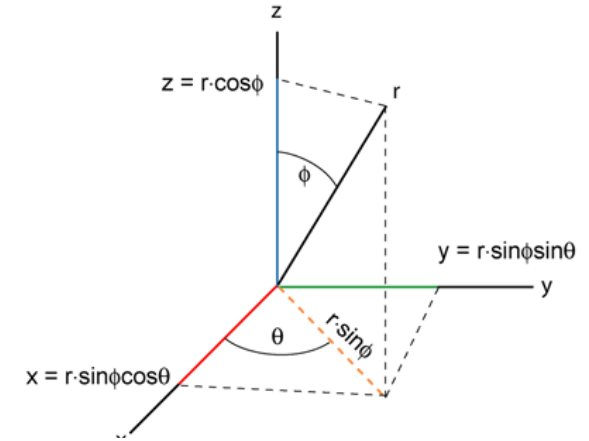
Log scales !!

To do trigger scan!

MIP reconstruction - Beam studies

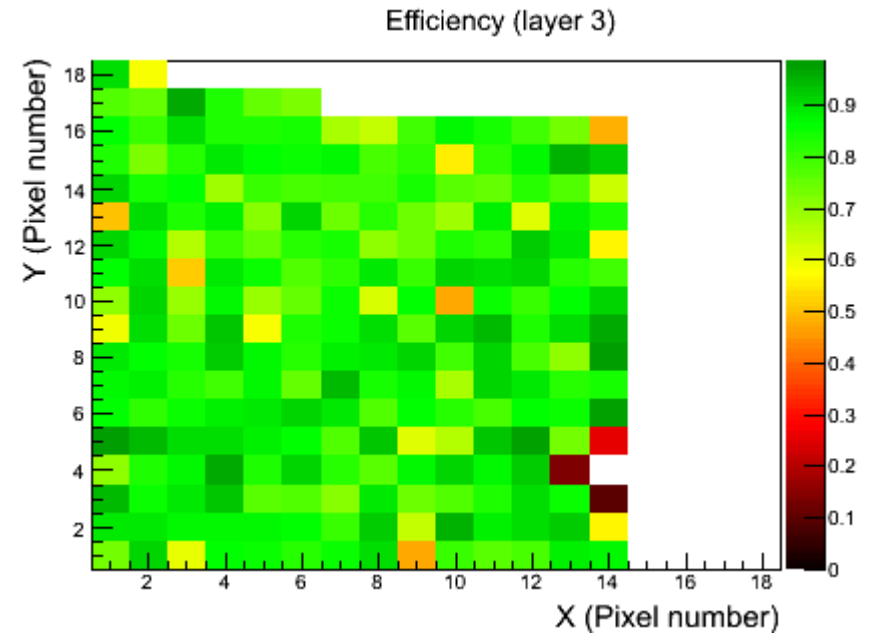
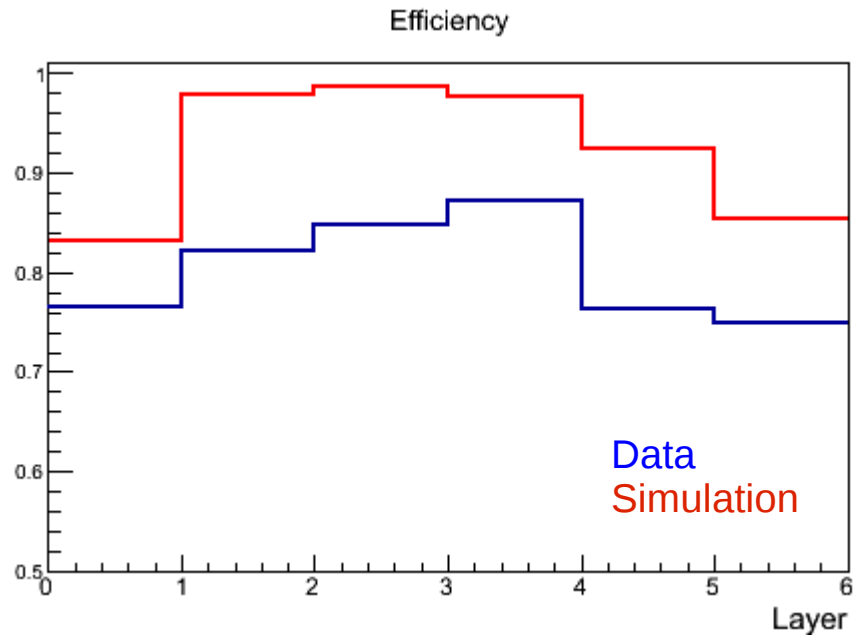
Beam reconstruction

- Phi: gaussian distribution, sigma = 1°



To do trigger scan!

Detection efficiency

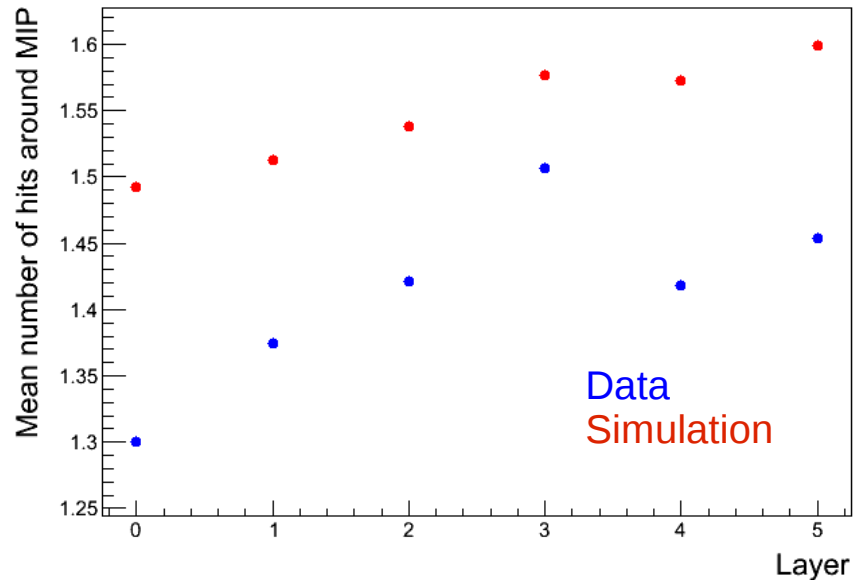
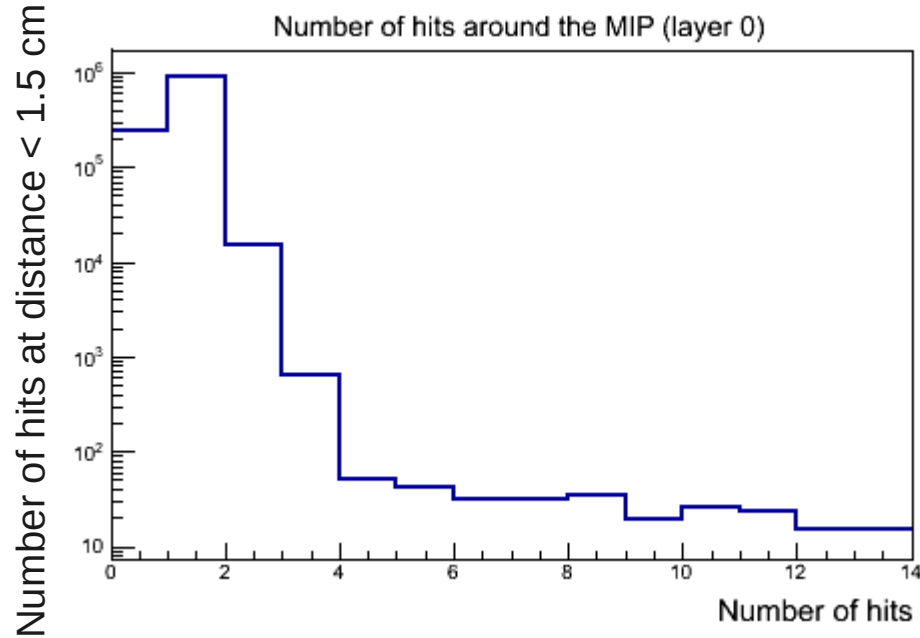


- Low efficiency close to switched off channels
But some isolated low efficiency channels (to be investigated)
- Efficiency depends on the beam parameters (angle)
~~Need real beam parameters in simulation~~ --> DONE
- Some effects not yet in the simulation (noise, trigger...)

To do trigger scan!

On going analysis!

Number of hits around MIP



- Some effects not yet in the simulation (noise, trigger...) **To do trigger scan!**
- Check correlation between the number of hits around MIP and the trigger threshold

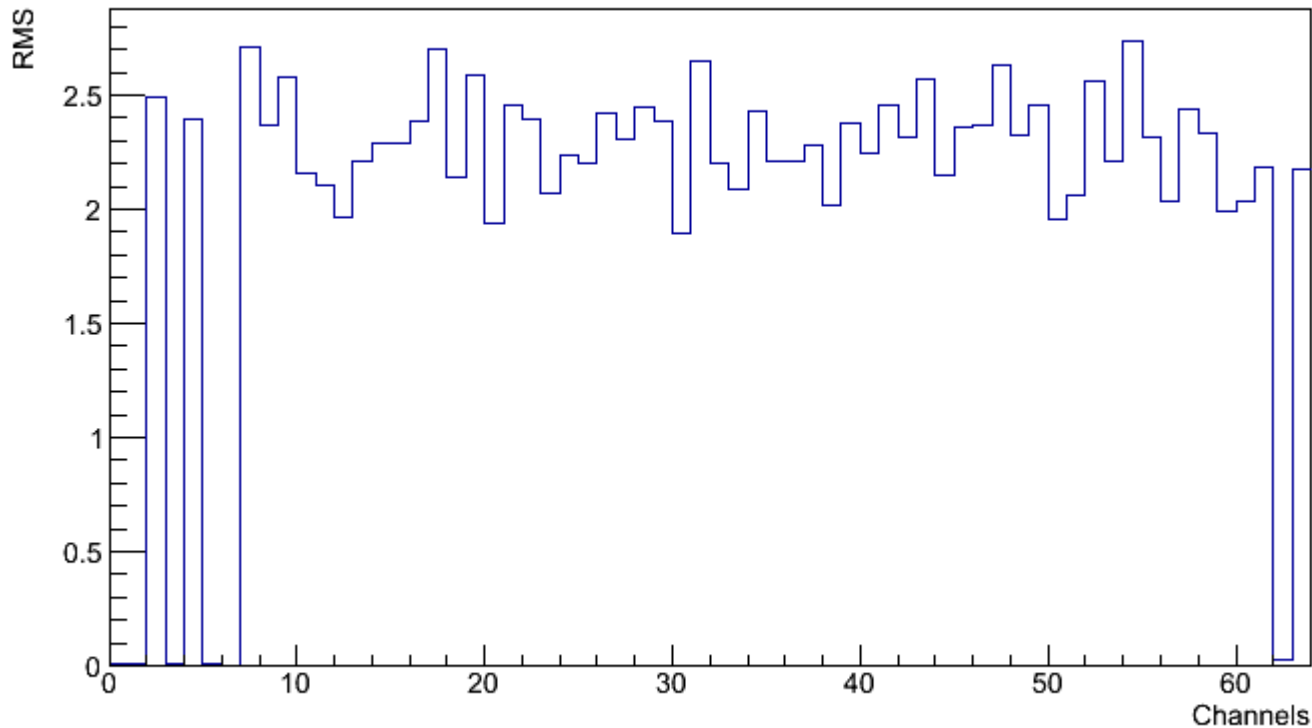
Correlation studies

Correlation studies

- Extract coherent noise source + intensity

Chip M1: Sigma total ~ 3.5 ADC

\Rightarrow 1 source for all layers ($\langle \sigma \rangle \sim 2.3 - 2.5$)

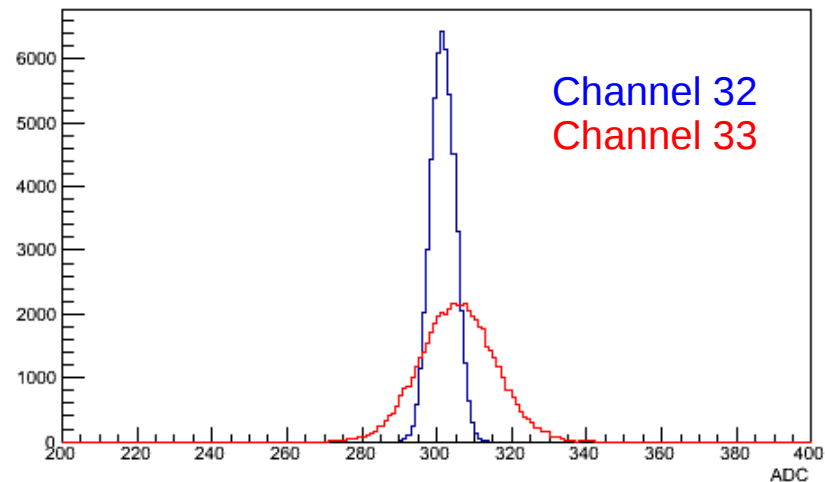
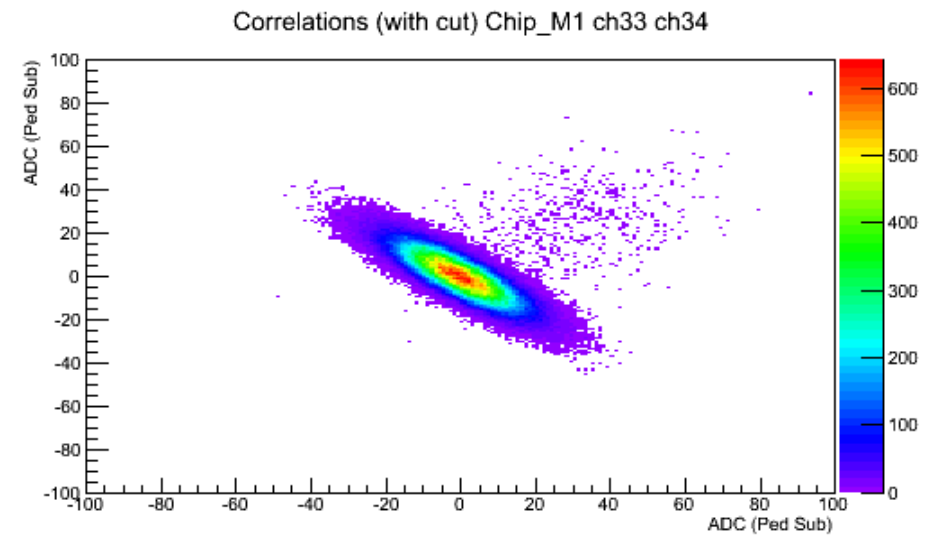
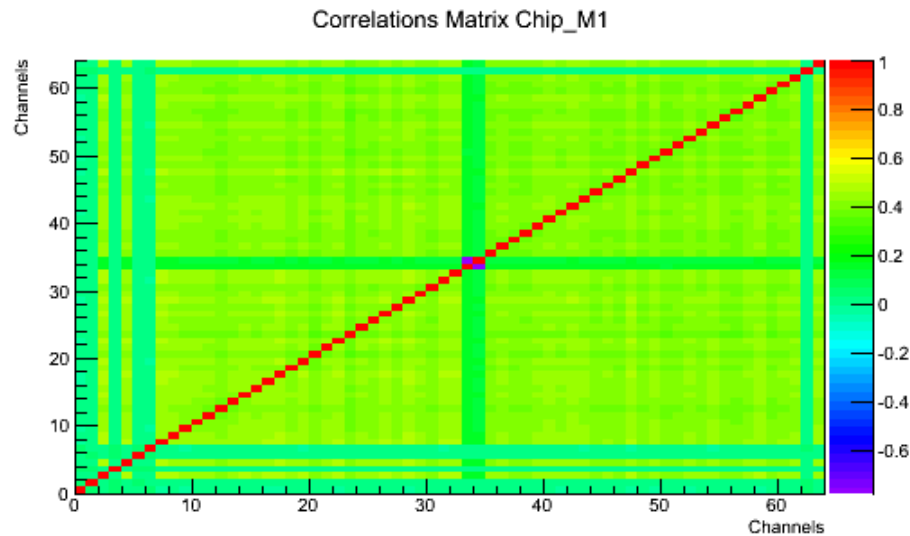


To do: check fluctuations with XY channel position

Correlation studies

- Chip M1: Sigma total ~ 3.5 ADC

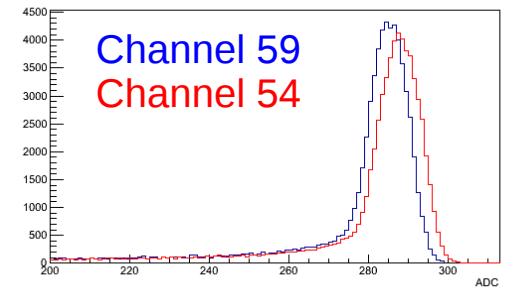
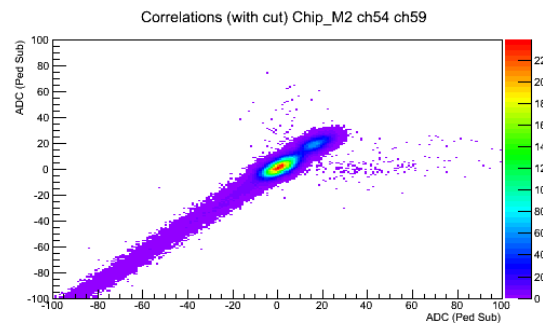
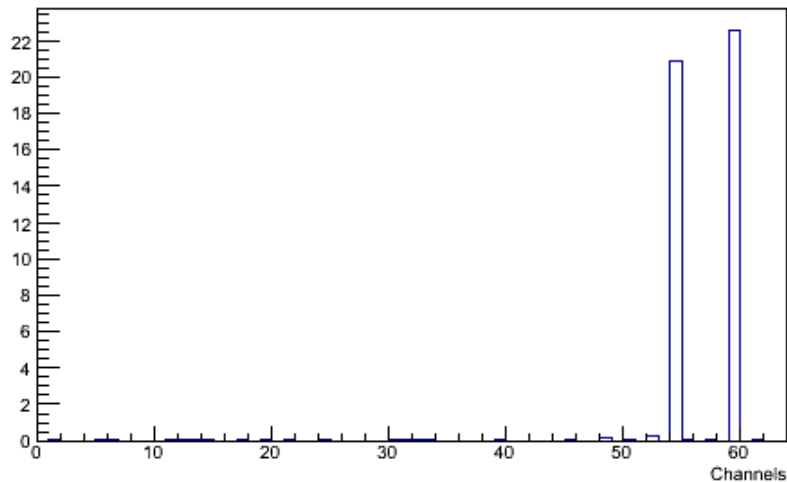
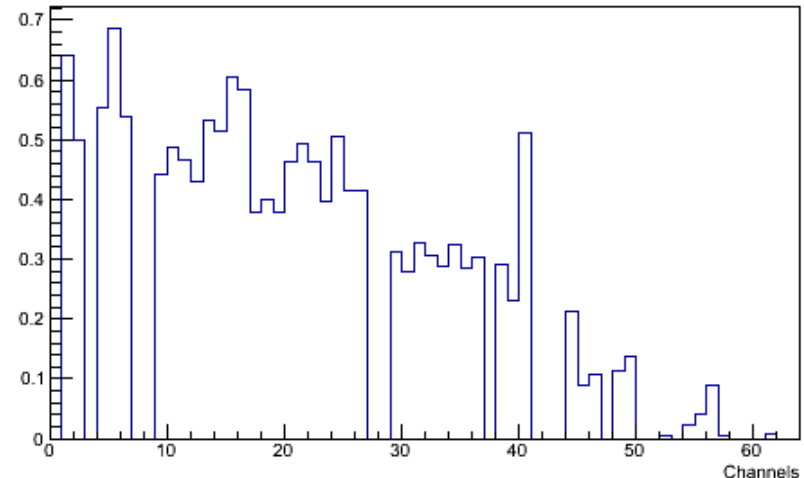
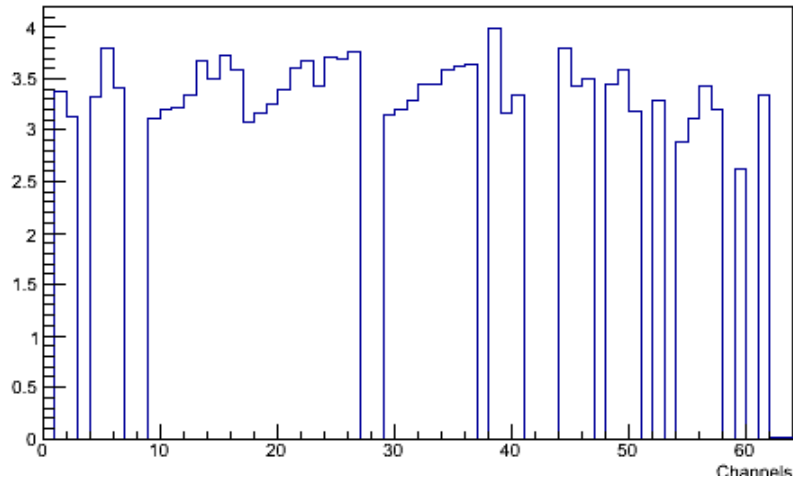
==> Layer 2



Correlation studies

Chip M2: Sigma total ~ 4 -5 ADC

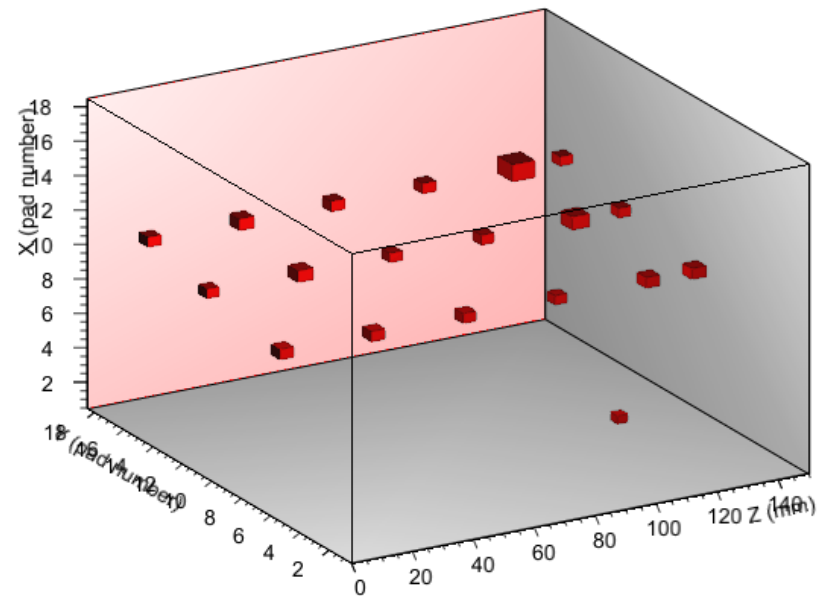
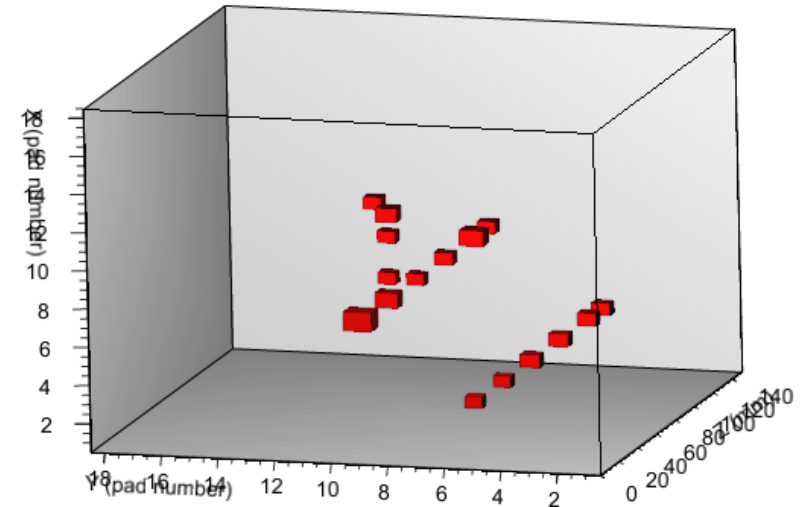
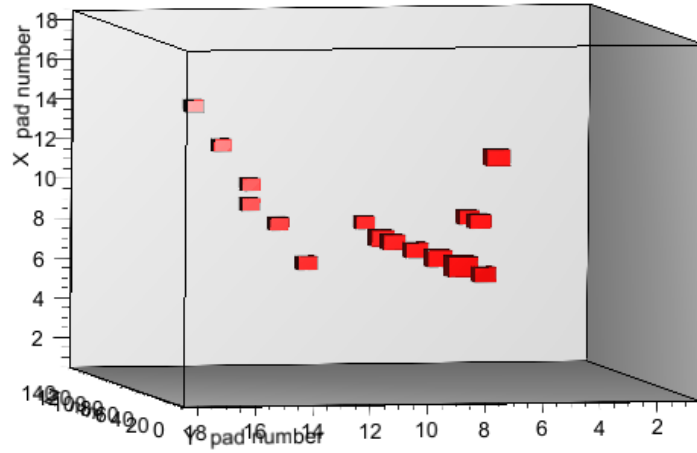
\Rightarrow 3 sources for all layers



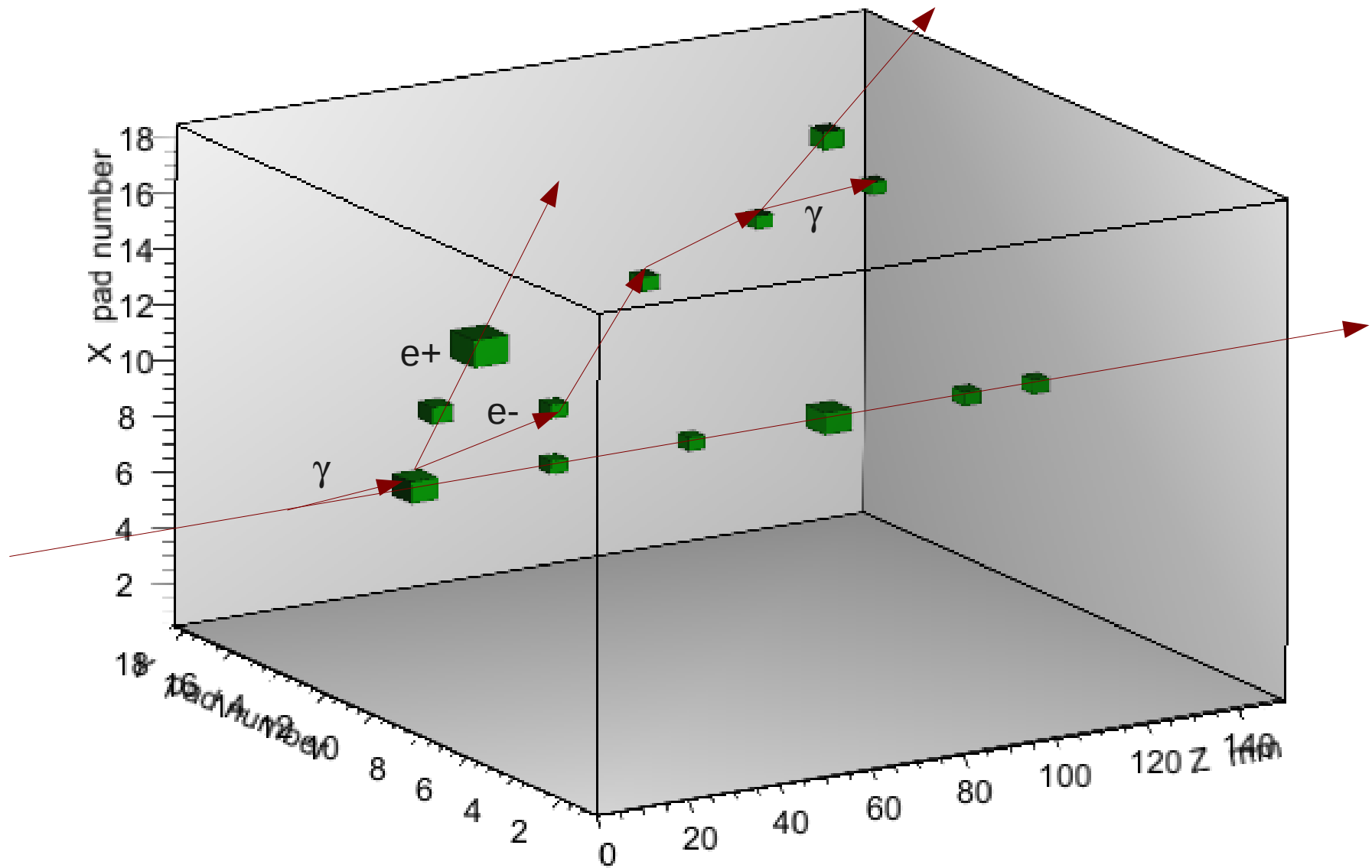
To do: check intensity variations with XY channel position
Is higher sigma total only due to higher coherent noise?

Event display

Event display



Event display



Summary

- Analysis in progress:
 - Beam reconstruction
 - MIP studies --> Trigger threshold scan: efficiency
 - Crosstalk --> on going, to be check with special runs
 - BCID+1, plane events.... on going
 - Energy calibration + Homogeneity of response : **DONE**
 - Determine signal over noise ratio of the detector: **DONE**
 - Study of showers
- See Jeremy's talk
- See Elmaddin's talk

Back up

Setup

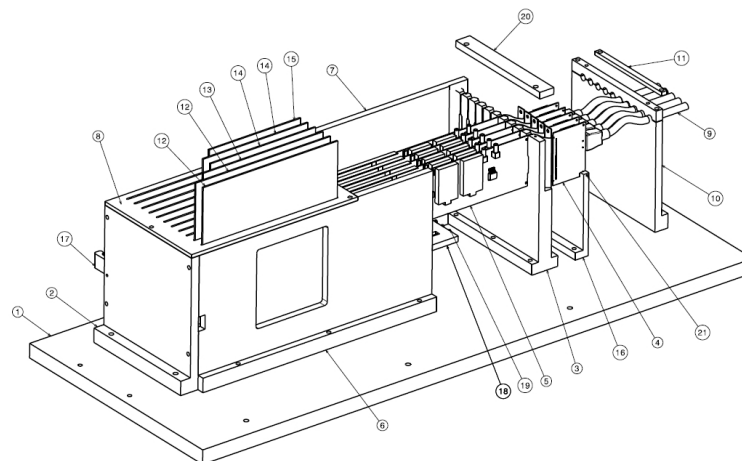
- wafer 9x9 cm², 324 pixels 5x5 mm²
- 6 FEV8 (4 SKIROCs per FEV)
 - 4 SKIROCs x 64 channels = 256 channels
(2 channels with 2 pixels and 22 channels with 4 pixels)

Total = 1536 channels

PreAmplifiers of noisy channels are switched off

total active channels = 1278

- PVC structure with position for tungsten plates (2.1 mm)



21	Support Plate	CAL-12-03-11	1	PVC		
20	Wafer	CAL-12-03-11	1	PVC		
19	Support Plate	CAL-12-03-09	1	PVC		
18	Wafer	CAL-12-03-07	1	PVC		
17	Support Plate	CAL-12-03-14	1	PVC		
16	Wafer	CAL-12-03-12	1	PVC		
15	Support Plate	CAL-12-03-11	1	PVC		
14	Wafer	CAL-12-03-11	2	PVC		
13	Support Plate	CAL-12-03-11	1	PVC		
12	Wafer	CAL-12-03-11	2	PVC		
11	Support Plate	CAL-12-03-11	1	PVC		
10	Wafer	CAL-12-03-11	1	PVC		
9	Support Plate	CAL-12-03-11	1	PVC		
8	Wafer	CAL-12-03-11	1	PVC		
7	Support Plate	CAL-12-03-11	1	PVC		
6	Wafer	CAL-12-03-11	1	PVC		
5	Support Plate	CAL-12-03-11	1	PVC		
4	Wafer	CAL-12-03-11	1	PVC		
3	Support Plate	CAL-12-03-11	1	PVC		
2	Wafer	CAL-12-03-11	1	PVC		
1	Support Plate	CAL-12-03-11	1	PVC		
100	Designation	N°Plan	N°de Matériau	Traitement	Observation	